

# MCT photoconductive detector P2748/P5274 series, P3257-50

Dewar type detector with high sensitivity and high-speed response in long wavelength range



### Features

- Choice of spectral response range (up to 25  $\mu\text{m}$ )  
The band gap can be adjusted by controlling the composition ratio of HgTe and CdTe. Utilizing this fact, various types are available in different spectral characteristics.
- Photoconductive element that decreases its resistance by input of infrared light
- Micro-cooled type available  
This type of cooling does not require pour-filled liquid nitrogen.
- Custom devices available  
Custom devices not listed in this catalog are also available with different spectral response, active area sizes and number of elements.  
Glass dewar type not requiring repumping is also provided.

### Applications

- FTIR
- Infrared spectrophotometer
- Thermal imaging
- Remote sensing
- CO<sub>2</sub> laser detection

### Accessories (Optional)

- Valve operator A3515
- Amplifiers for dewar type MCT photoconductive detector C5185
- Power supply for amplifier C3871
- Infrared detector module with preamp P7752-10

### General rating / Absolute maximum ratings

Type No.	Dimensional outline/ Window material *1	Package	Cooling	Active area (mm)	Nitrogen maintenance time Min. (h)	Absolute maximum ratings		
						Allowable current (mA)	Operating temperature Topr (°C)	Storage temperature Tstg (°C)
P2748-40	①/Z	Side-on type metal dewar	LN <sub>2</sub>	1 × 1	12	40	-40 to +60	-55 to +60
P2748-41	②/Z	Head-on type metal dewar		1 × 1		40		
P2748-42	①/Z	Side-on type metal dewar		0.25 × 0.25		20		
P5274				1 × 1		40		
P5274-01				①/K		1 × 1		
P3257-50	③/Z	Stirling type metal	Micro-cooled	1 × 1	-	40	-40 to +55	-45 to +55

### Electrical and optical characteristics (Typ. unless otherwise noted)

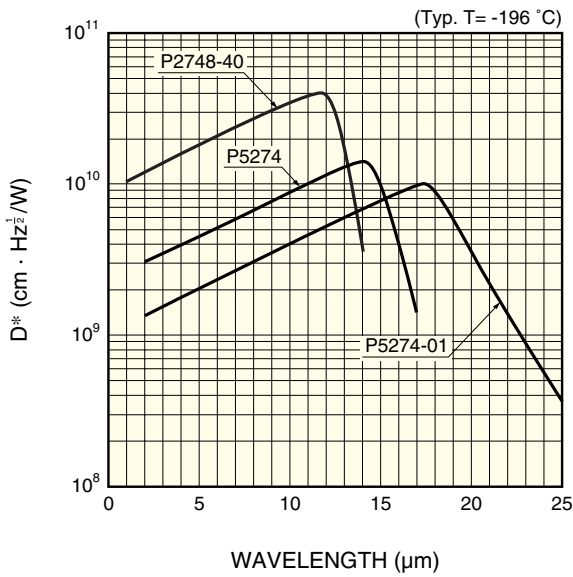
Type No.	Measurement condition Element temperature T (°C)	Peak sensitivity wavelength $\lambda_p$ ( $\mu\text{m}$ )	Cut-off wavelength $\lambda_c$ ( $\mu\text{m}$ )	Photo sensitivity *2 S $\lambda = \lambda_p$ (V/W)	D* (500, 1200, 1)		D* ( $\lambda_p$ , 1200, 1) ( $\text{cm} \cdot \text{Hz}^{1/2}/\text{W}$ )	NEP $\lambda = \lambda_p$ (W/Hz <sup>1/2</sup> )	Rise time tr 0 to 63 % ( $\mu\text{s}$ )	Dark resistance Rd ( $\Omega$ )		
					Min. ( $\text{cm} \cdot \text{Hz}^{1/2}/\text{W}$ )	Typ. ( $\text{cm} \cdot \text{Hz}^{1/2}/\text{W}$ )						
					P2748-40	-196					12	14
P2748-41	1000	2.5 × 10 <sup>-12</sup>										
P2748-42	10000	6.3 × 10 <sup>-12</sup>										
P5274	14	17	500	2 × 10 <sup>9</sup>	1 × 10 <sup>10</sup>		1.5 × 10 <sup>10</sup>	6.7 × 10 <sup>-12</sup>	0.6	30		
P5274-01	17	22	250	1 × 10 <sup>9</sup>	5 × 10 <sup>9</sup>		1.0 × 10 <sup>10</sup>	1.0 × 10 <sup>-11</sup>	0.4	100		
P3257-50	12	14	1000	1 × 10 <sup>10</sup>	2 × 10 <sup>10</sup>		4.0 × 10 <sup>10</sup>	2.5 × 10 <sup>-12</sup>	0.6	40		

\*1: Window material K: KRS-5, Z: ZnSe

\*2: Photo sensitivity changes with the bias current. The values in the above table are measured with the optimum bias current.

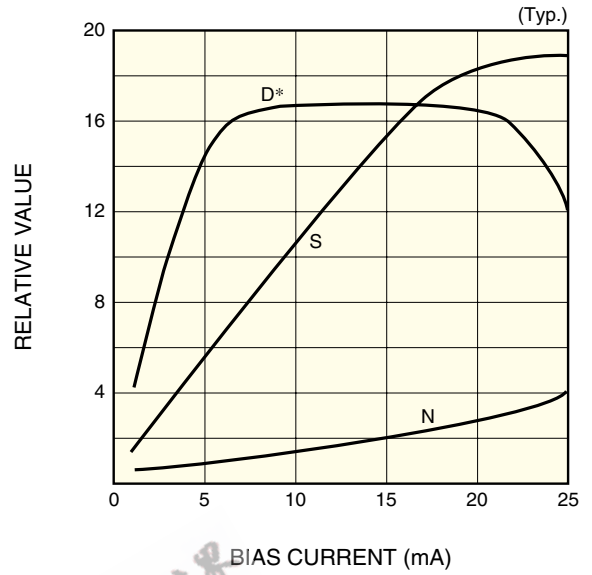
# MCT photoconductive detector P2748/P5274 series, P3257-50

## ■ Spectral response



KIRDB0072EC

## ■ S/N vs. bias current

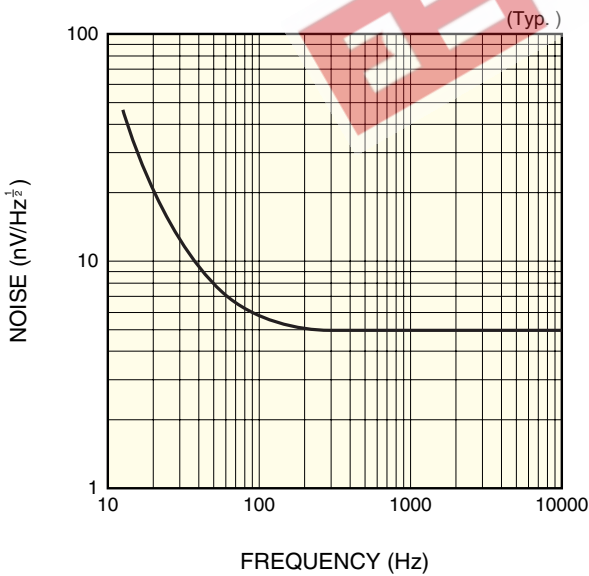


KIRDB0073EB

Spectral response can be shifted upon request.

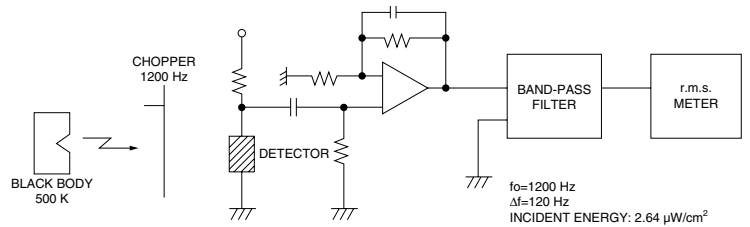
The detector must be operated in a range where the  $D^*$  becomes Max.

## ■ Noise frequency characteristic



KIRDB0074EC

## ■ Measurement circuit

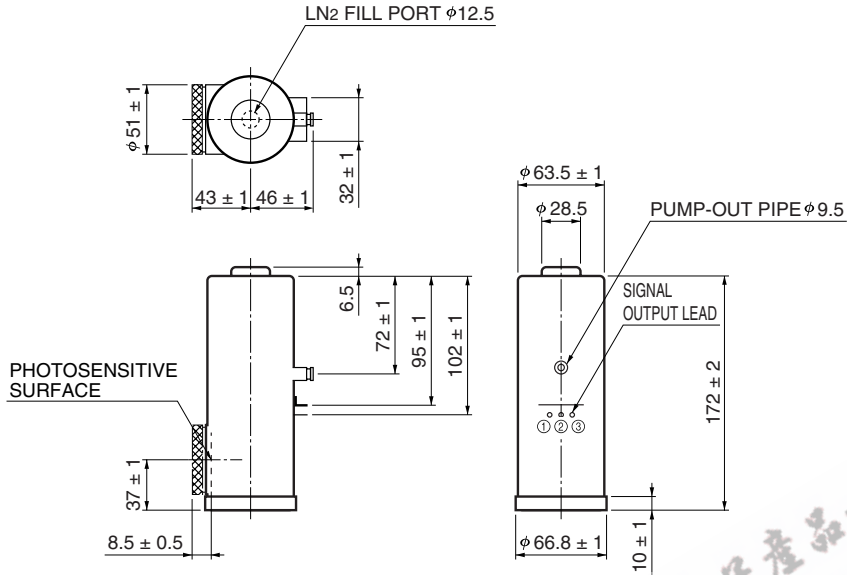


KIRDC0007EA

# MCT photoconductive detector P2748/P5274 series, P3257-50

## Dimensional outlines (unit: mm)

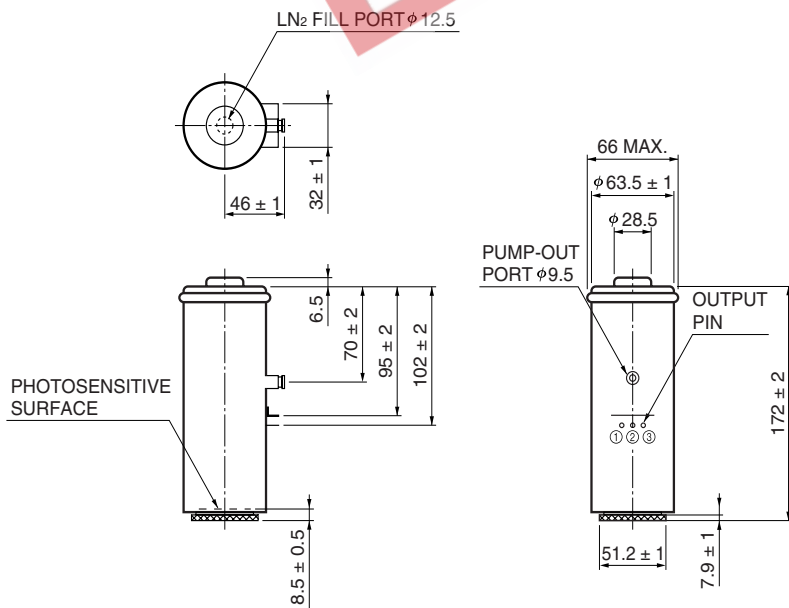
### ① P2748-40/-42, P5274 series



- ① DETECTOR
- ② NC
- ③ DETECTOR

KIRDA0131EC

### ② P2748-41



- ① DETECTOR
- ② NC
- ③ DETECTOR

KIRDA0129EA

